#### Electro-optical Detector for the Temporal Characterization of Picosecond and Femtosecond Beam Bunches

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#### <u>Outline</u>

Motivation Method Data/Results

Euturo

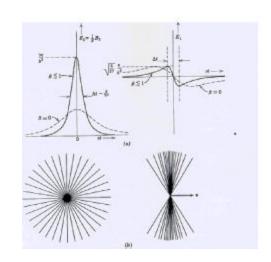
Future



### **Motivation:**

- •Develop a Charged Particle Beam Detector
- •Temporal Resolution ps to sub-ps
- •Non-destructive
- •Single Shot







# Method: Electro-optical Effect

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- •In amorphous optical media: Kerr effect  $f = 2pKE^2d$
- •In Uniaxial Crystals: Pockels effect f = (2p/l)pEl  $E = qN = qN \times q$
- •E-field from a charged

particle beam:

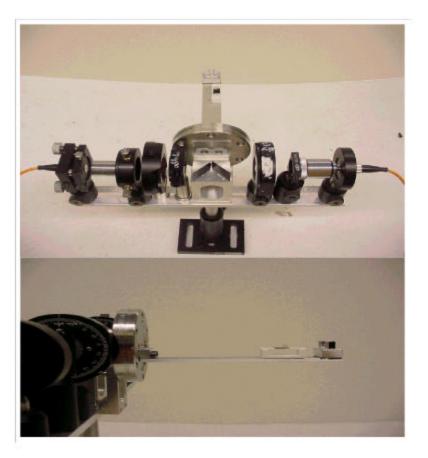
$$E = \mathbf{g} N_e \frac{\mathbf{q}}{4\mathbf{p} \mathbf{e}_0 \mathbf{e}_r r^2} = \mathbf{g} N_e \times 2 \times 10^{-6} \,\mathrm{V/m}$$
  
for  $\Delta t = \frac{r}{\mathbf{g} u} = \frac{17}{\mathbf{g}} \,\mathrm{ps}$ , for  $r = 5 \,\mathrm{mm}$   
 $\mathbf{f} = \frac{q p N_e}{\mathbf{g} v} = N_e \times 10^{-12} \,\mathrm{rod}$ 

 $\approx$  3mrad for 0.5nC of Beam.

$$\boldsymbol{f} = \frac{\boldsymbol{q} p \boldsymbol{r} \boldsymbol{v}_{e}}{2\boldsymbol{e}_{0}\boldsymbol{e}_{r} n r \boldsymbol{l}} = N_{e} \times 10^{-12} \text{ rad}$$

### 10<sup>10</sup> Electron Pulsed Beam, 10-15ps long, 1mm diameter, 1.5 Hz from ATF of BNL

LiNbO<sub>3</sub> Crystal as E-field Sensor



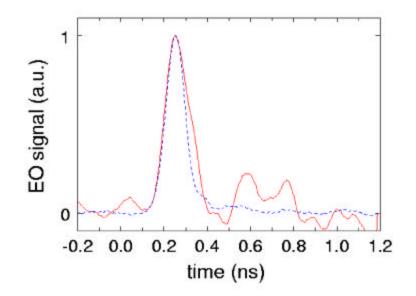
Brookhaven Scier U.S. Departmer



### 10<sup>10</sup> Electron Pulsed Beam, 10-15ps long, 1mm diameter, 1.5 Hz from ATF of BNL

LiNbO<sub>3</sub> Crystal as E-field Sensor

**Readout with Conventional Electronics** 



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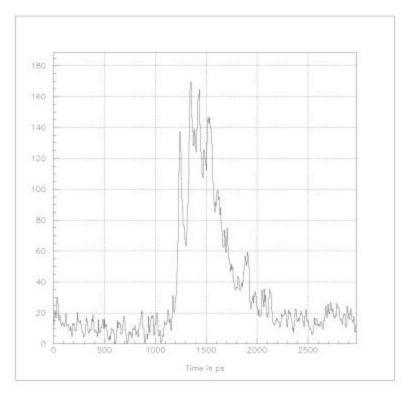
Fig.

### 10<sup>10</sup> electron pulsed beam, 10-15ps long, 1mm diameter, 1.5 Hz from ATF of BNL

#### LiNbO<sub>3</sub> crystal as E-field sensor

Streak Camera

**Single Shot** 



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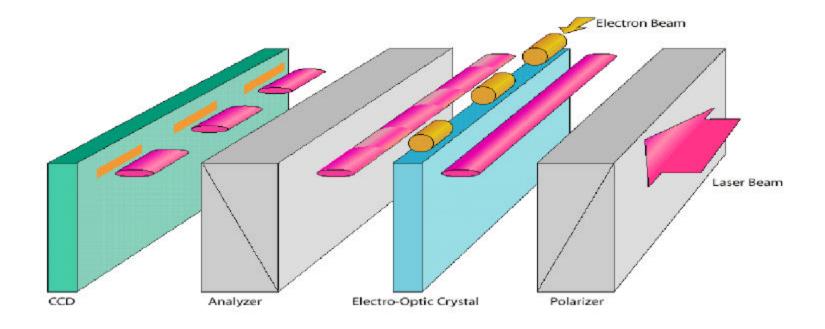
### Future:

Electro-optical Effect with Flash Photography

- •Temporal Resolution better than 100fs
- •Transformation of time distribution to spatial avoids electronic time resolution limitations
- Convenient real time measurement
- characterizing individual beam bunches in single shot
- •Promising Diagnostic Technique for Linear Collider and Free Electron Laser Development



### <u>Electro-optical Effect with</u> <u>Flash Photography</u>



## **Publications:**

Charged Particle Beam Detection via Electro-optical Effects

•Y.K. Semertzidis *et al.*, Proceedings of the 1999 Particle Accelerator Conference, 490 (1999).

•D.M. Lazarus *et al.*, Proceedings of the International Europhysics Conference on High Energy Physics, 993 (1999).

•Y.K. Semertzidis *et al.*, Nucl. Inst. Meth. {\bf A452}, 396 (2000).

•T. Tsang et al., J. Appl. Phys., {\bf 89}, 4921 (2001).

•T. Srinivasan-Rao *et al.*, 21st ICFA Beam Dynamics Workshop on Laser-Beam Interactions (2001). Proceedings to be published in the Physical Review Special Topics. Brookhaven Science Associates U.S. Department of Energy 9

## **Conclusion:**

•Proof of Principle of Electro-optic Effect with Beams (BNL LDRD, work at ATF)

•Promising New Method with Temporal Resolution better than 100fs (proposal to DOE)

•Non-destructive

•Single Shot



